


<b>Search Notes</b>  	<b>Application/Control No.</b>  10526587	<b>Applicant(s)/Patent Under Reexamination</b>  SANO, AKIRA
	<b>Examiner</b>  ESTHER BENOIT	<b>Art Unit</b>  2442

SEARCHED			
Class	Subclass	Date	Examiner
709	203,245	4/08	bb
709	223	12/17/2008	EB
709	203, 245	7/14/2009	EB
709	223	7/7/2009	EB

SEARCH NOTES		
Search Notes	Date	Examiner
(707/3-6, 10, 104.1; 709/223, 226) and UDDI\$	4/08	bb
Consulted w/ Andy Caldwell re search	4/08	bb
EAST - See attached history	4/08	bb
PLUS search	4/08	bb
Inventor name search	4/08	bb
Text Search of USPAT, USPGPUB, Derwent, IBM_TDB, EPO, JPO	12/16/2008	EB
Limited classified search of 709/223	12/17/2008	EB
Google Scholar Search	12/17/2008	EB
Update Search	7/7/2009	EB
Assignee Search	7/7/2009	EB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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